

PER-V100

CHRONTEL 7009 CHIPSET AGP BOARD

Thermal Image Analysis Report

Report No:05I080008

Release Date: 10. 25.2005

2005/10/25

Issue Stamp

Wenyuan Yang

Manager

Liping Hsieh

Test Engineer

Thermal Image Analysis

I . Model Name: PER-V100 Rev.A0.1

HSB-835A A1.0

BIOS: HSB-835A BIOS Rev:1.2 For 7009 Chip

Backplane : BP-214 SA-P616 A1.1

II . Description: CHRONTEL 7009 CHIPSET AGP BOARD

III . Date: 10.25.2005

IV . Measure Site: AAEON QE Dept.

V . Issued by : Liping Hsieh

VI.Equipment:

1. TVS-100 series by NIPPON AVIONICS CO., LTD.

VII. Simulation Environment:

•Temperature: Component Side : 26.0°C

Solder Side : N/A

•CPU: Intel / Pentium 4 CPU 2.0GHz/400

•RAM: SAMSUNG /K4H560438E-GCCC / DDR400 /512MB

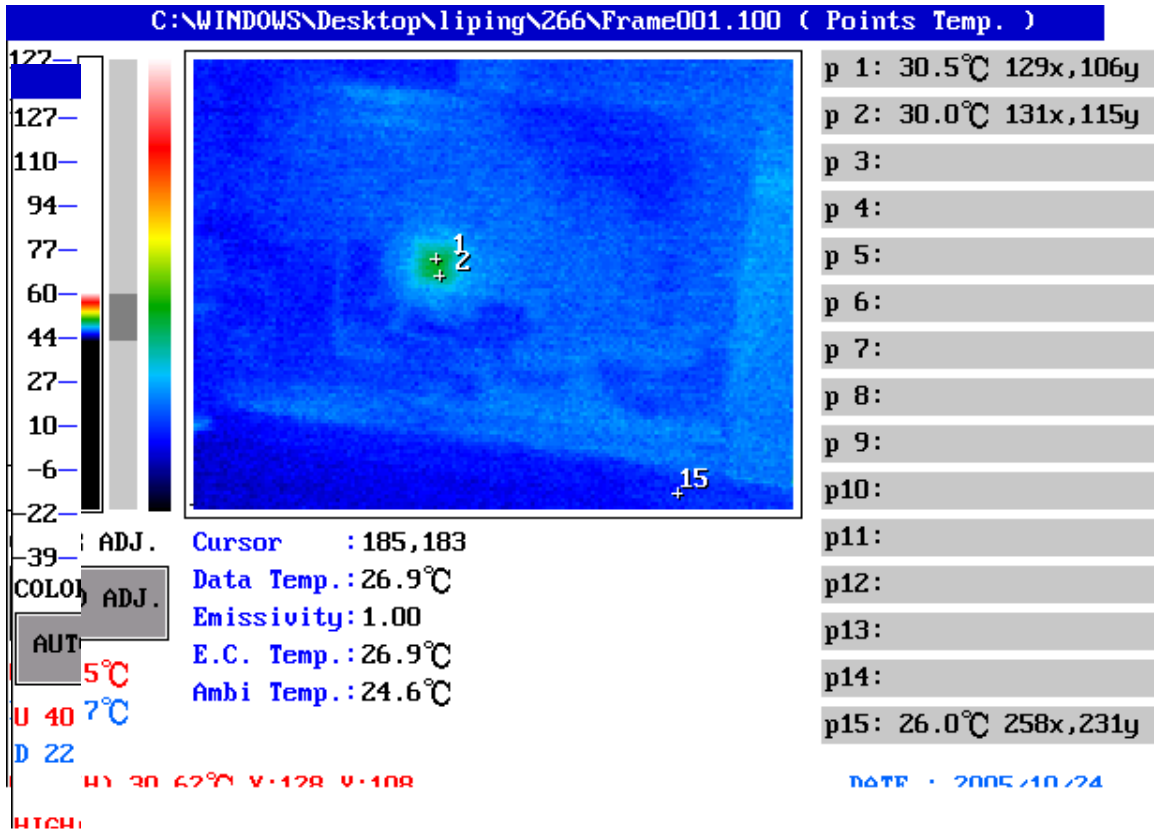
•CF Card: N/A

•Application Software: Run HCT System Stress Test under Win2000 Professional

•Take Picture Time: After Power on 2 hours.

Temperature Profile Test:

Component Side



| Point | Position | Describe | Tc (°C) | Tm (25°C) | Tm (60°C) | Note |
|-------|----------|--|------------|-----------|-----------|------|
| 1 | U3 | CHRONTELINC/CH7009A/IC.SMDLQFP.64PDVI/TV | 125°C | 30.5°C | 65.5°C | |
| 2 | Y2 | X TAL.DIP.14.318MHz.2P.16pf/30ppm. | -20°C~70°C | 30.0°C | 65°C | |
| 3 | | | | | | |
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| 10 | | | | | | |
| 11 | | | | | | |
| 12 | | | | | | |
| 13 | | | | | | |
| 14 | | | | | | |
| 15 | | | | 26.0°C | | |

1. Operation Temperature (°C):
 $T_c(\text{Case Temp.}) = T_a(\text{Ambient Temp.}) \pm 30^\circ\text{C} = T_j(\text{Junction Temp.}) \pm 25^\circ\text{C}$

Note: The description in red states which temperature is over the specification of the device.